**FORM PTO-1449** 

## U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE

# LIST OF REFERENCES CITED BY APPLICANT Jin Baek KI

(Use several sheets if necessary)

ATTORNEY DOCKET NO.	APPLICATION NO.
1594.1310	Unassigned
FIRST NAMED INVENTOR	
Jin Baek KIM, et al.	
FILING DATE	GROUP ART UNIT
December 31, 2003	Unassigned

#### **U.S. PATENT DOCUMENTS**

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#### **FOREIGN PATENT DOCUMENTS**

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OTHER REFERENCES (INCLUDING AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.)

DIN	AM	Korean Patent Abstracts for Publication No. 1020020086142, dated November 18, 2002
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### LIST OF COPENDING APPLICATIONS

	ATTACHMENT 1(f)
ATTORNEY DOCKET NO.	APPLICATION NO.
1594.1310	10/748,195
FIRST NAMED INVENTOR	
Jin Baek KIM, et al.	
FILING DATE	GROUP ART UNIT
December 31, 2003	Unassigned

The following, prior-filed, copending U.S. patent application(s) is/are listed in accordance with the duty of disclosure provisions of 37 CFR § 1.56, so that the Examiner may consider same should he deem any thereof to be material to examination of the subject application. Pursuant to 37 CFR 1.98(a)(2)(iii), a copy of the identified copending application(s) is provided.

It is requested that the Examiner acknowledge his consideration of application(s) below-listed by initialling same in the space provided adjacent each such application and that the Examiner sign and date this form at the bottom thereof to confirm such consideration having been given.

This submission in no way represents an admission that any of the information listed herein constitutes prior art with respect to the subject application and unless and until such prior art status is established, this submission is not a request that the information presented herein be printed on the face of any patent issuing from the subject application in which this information is being filed.

**U.S. PATENT APPLICATION DOCUMENTS** 

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*EXAMINER INITIAL		U.S. SERIAL NO.	FILING DATE	NAME	ASSIGNEE
DIM	1	10/748,229	12/31/2003	Jin Baek KIM, et al.	Samsung Electronics Co., Ltd., Suwon-Si, Republic of Korea
MIC	2	10/748,230	12/31/2003	Jin Baek KIM, et al.	Samsung Electronics Co., Ltd., Suwon-Si, Republic of Korea
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